

Laboratoire de Physique des Solides
(Université Paris-Sud, Orsay)

V. Jeudy, J. Ferré, J. Gorchon, A. Mougin, J.-P. Jamet,
P. Metaxas, V. Repain, M. Bauer, S. Lemerle,

Collaborations:

V. Baltz, B. Rodmacq (Inst. L. Néel, Grenoble)

S. Bustingorry, A. Kolton (C.A. Bariloche)

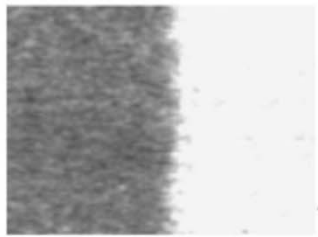
T. Giamarchi (Univ. Geneva)

FIELD-DRIVEN DOMAIN WALL MOTION

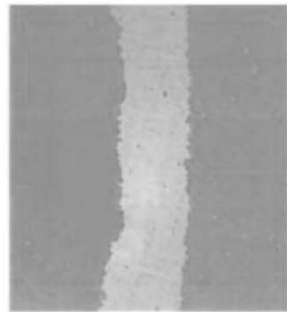
IN FERROMAGNETIC FILMS WITH WEAK DISORDER



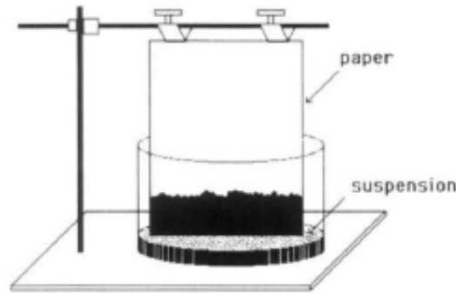
MOTION OF AN ELASTIC INTERFACE IN A WEAKLY DISORDERED SYSTEMS



Domain walls
in ferroelectric films



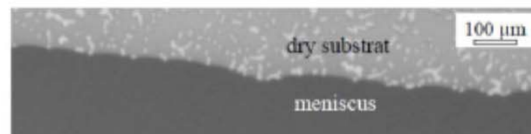
Domain walls
in ferromagnetic films



Fluid impregnation



Bacteria colonies



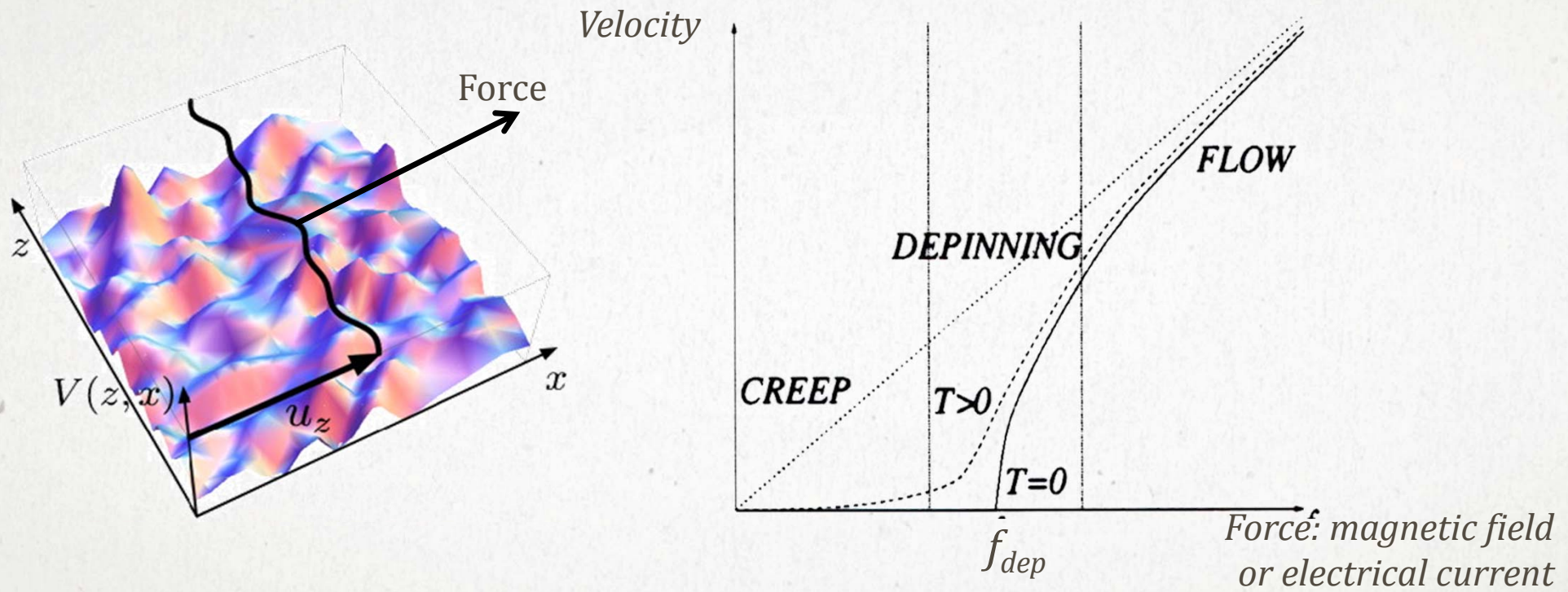
Fluid wetting

1D interface, 2D medium; similar

Universal behavior:
different physics at the microscopical scale,
same description at the macroscopical level ?

To what extends interface motion can be
used to address some general problems in
statistical physics ?

FORCE DRIVEN MOTION OF AN INTERFACE: BASIC IDEAS



Magnetization reversal, depinning, current

OUTLINE

1- MAGNETIZATION REVERSAL IN FERROMAGNETIC THIN FILMS

2- THE CREEP REGIME AT CONSTANT TEMPERATURE

3- THERMAL STUDY OF PINNING DEPENDENT REGIMES

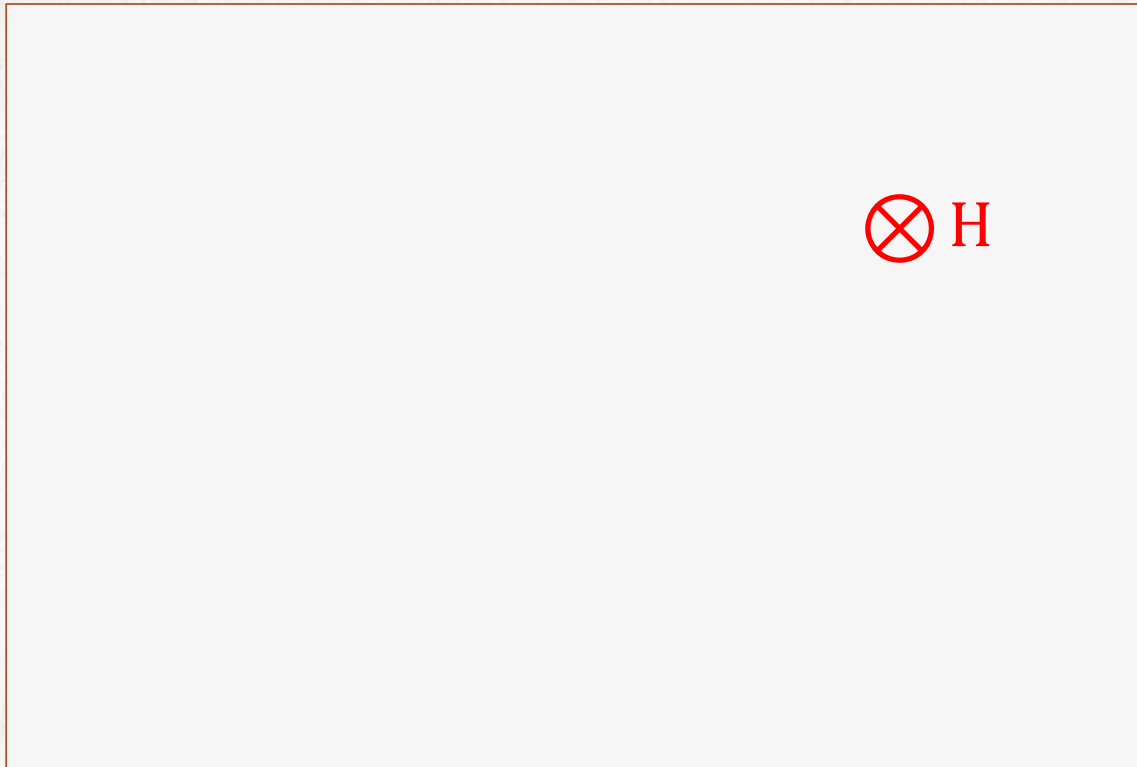
4- DOMAIN WALL MOTION DRIVEN BY AN ELECTRIC CURRENT

1- MAGNETIZATION REVERSAL IN FERROMAGNETIC THIN FILMS

- Pinning strength
- Magnitude of the driving force
- Method for DW velocity measurement
- DW dynamical regimes

STRONG PINNING DISORDER: NUCLEATION

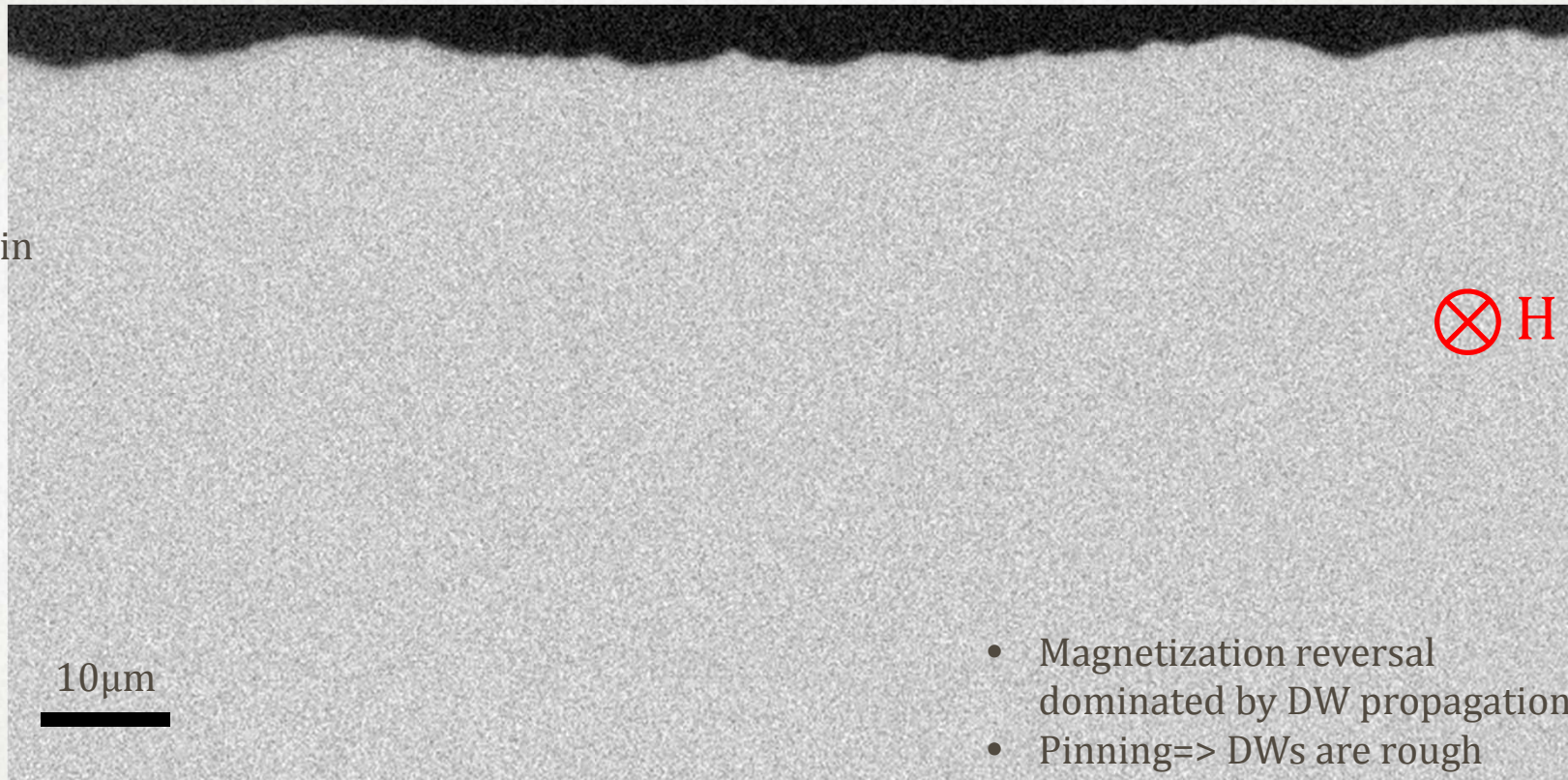
Polar MOKE image:
FePt thin film



- DW propagation impeded by DW pinning
- Magnetization reversal dominated by nucleation

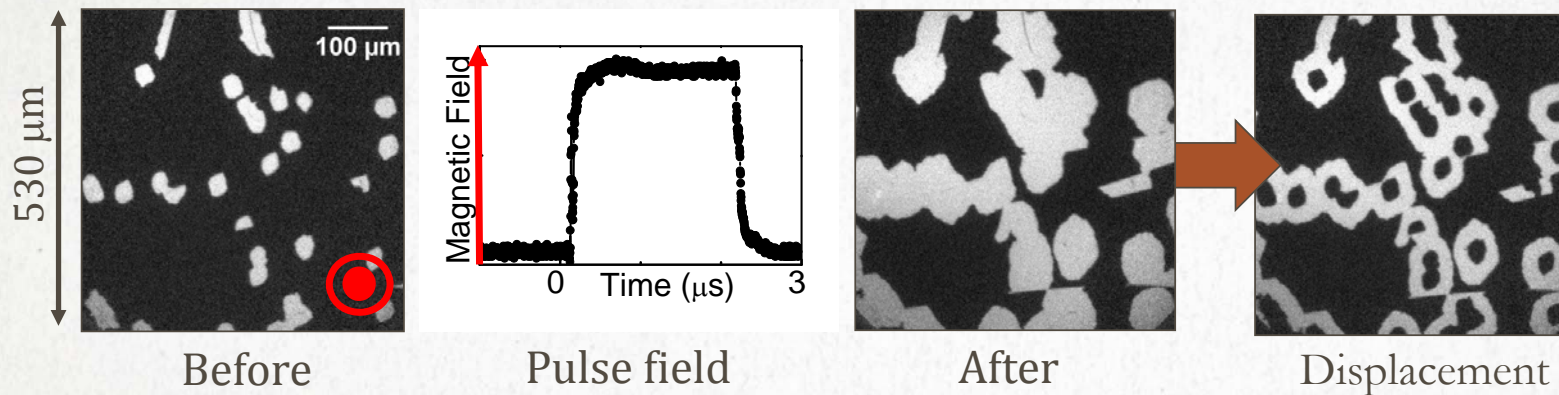
WEAK PINNING DISORDER: INTERFACES PROPAGATION

Polar MOKE
Pt/Co/Pt film thin
 $H=0.06H_{\text{dep}}$



MEASUREMENT OF DW VELOCITY

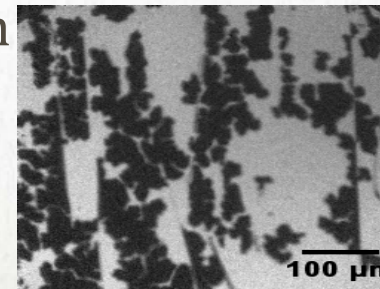
Magneto-optical Kerr microscopy and magnetic field pulses



Average velocity = DW displacement / pulse duration

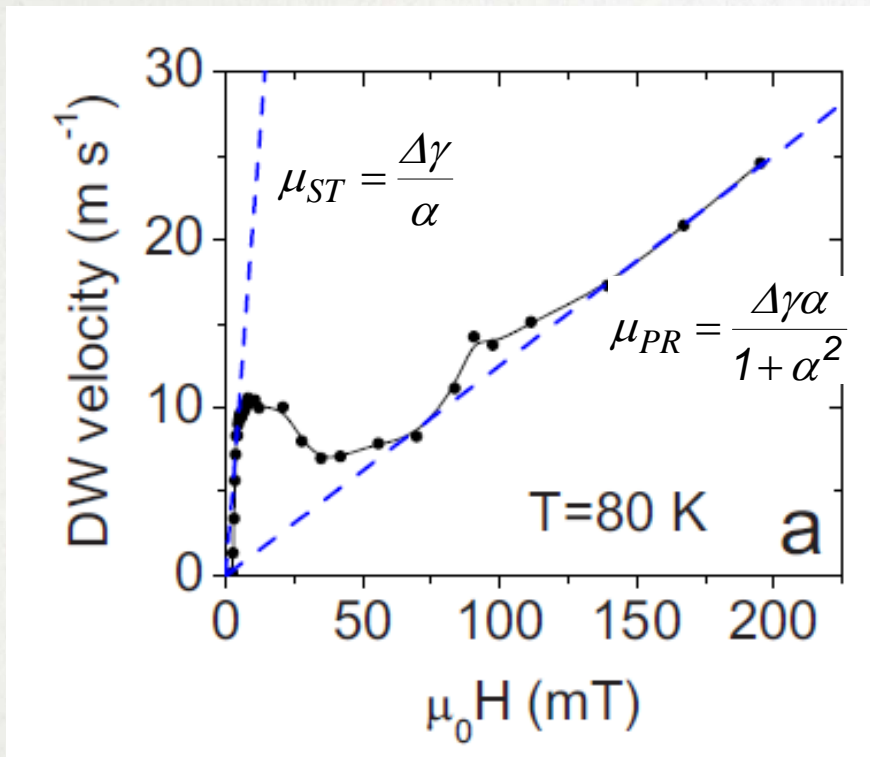
Limits :

- multiple nucleation at high field
- Strong and extended pinning defects



GaMnAs T=40 K

VERY WEAK PINNING DISORDER : FLOW REGIMES



(Ga,Mn)As 50nm thick film with PMA

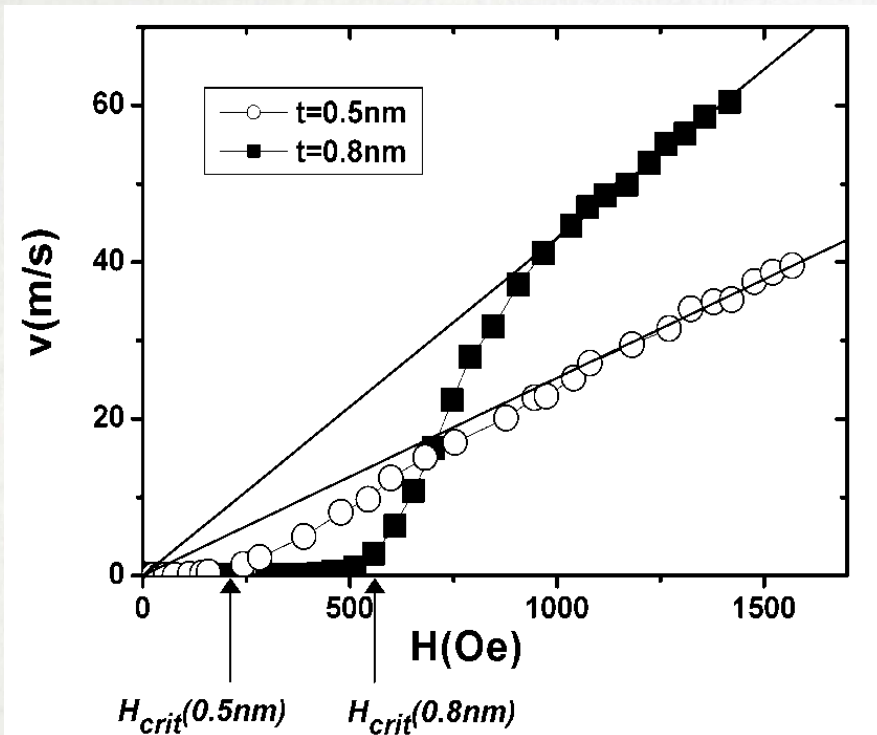
Dynamics

- Controlled by dissipation
- Depends on the magnetic structure of the domain wall

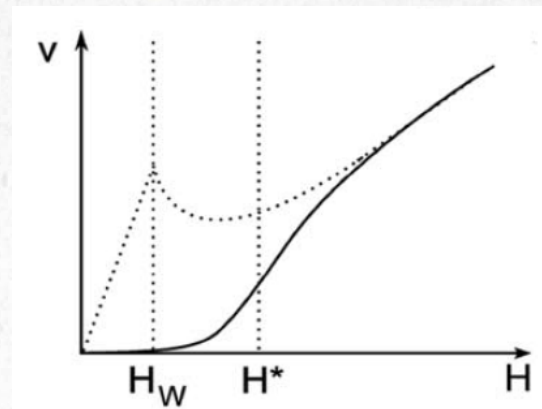
Different regimes

- Steady : fixed direction of magnetization \vec{M}
- Precessionnal : rotation of \vec{M}

WEAK PINNING DISORDER : HIGH FIELD FLOW REGIME



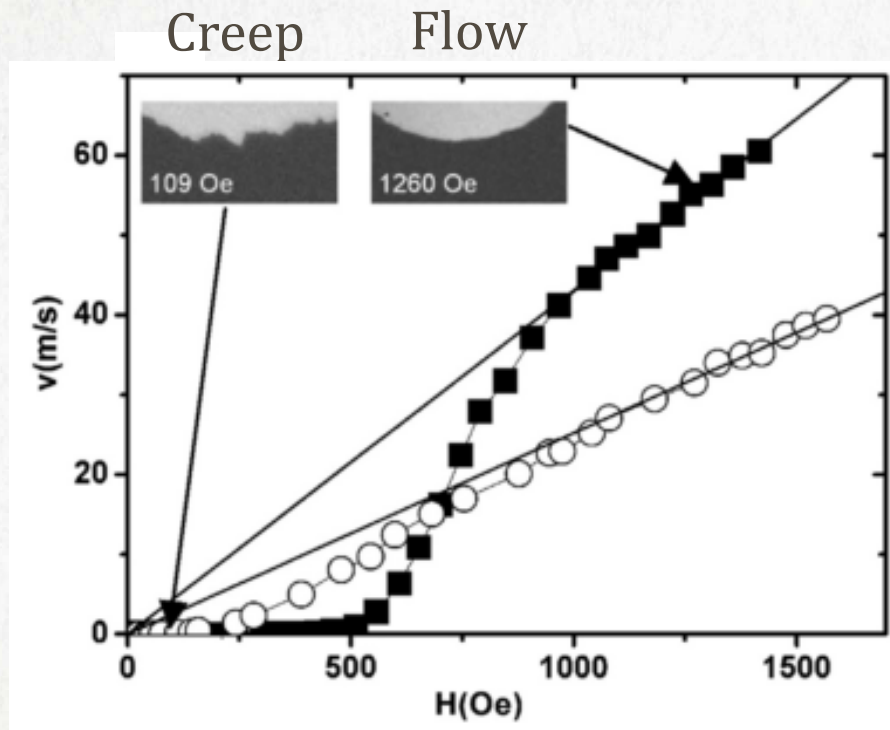
Pt/Co/Pt ultrathin film with PMA



Larger pinning strength \Rightarrow
The steady flow regime is hidden by pinning depend motion.

ROUGHNESS AND VELOCITY

Pt/Co/Pt
ultrathin films

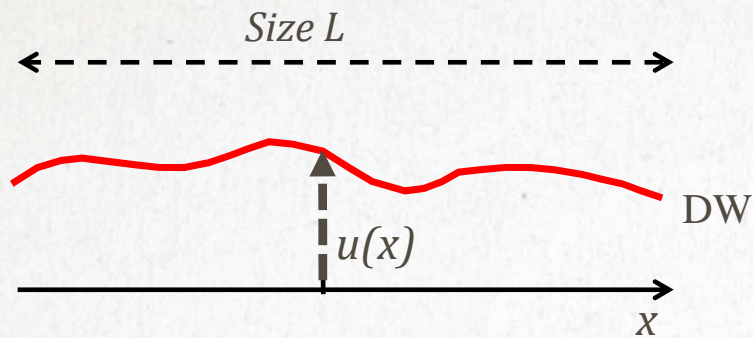


Creep: rough domain walls
Flow: smooth domain walls

2- THE CREEP REGIME AT CONSTANT TEMPERATURE

- Theoretical predictions and experimental results
- Controlling domain wall creep

CREEP REGIME: BASIC MODEL AND PREDICTIONS



Free energy of a DW segment of size L

$$F(L, u) = \underbrace{\epsilon_{el} \frac{u^2}{L}}_{\text{elastic}} - \underbrace{\epsilon_{pin} u \sqrt{n_i \xi L}}_{\text{pinning}} - \underbrace{M_s H t L u}_{\text{Zeeman}}$$

ξ : correlation length of the disorder

n_i : density of pinning centers

$\epsilon_{el} \approx 4\sqrt{AK}t$: elastic energy

$\Delta = \sqrt{A/K}$: domain wall thickness

Pinning control parameters

Larkin length $L_c \Leftarrow F_{elastic}(L_c, \xi) = F_{pinning}(L_c, \xi)$

Depinning field $H_{dep} \Leftarrow F_{pinning}(L_c, \xi) = F_{Zeeman}(L_c, \xi)$

Depinning temperature $k_B T_{dep} \approx F_{pinning}(L_c, \xi)$

Predictions

Velocity: $v_{creep} = v_{creep}^0 e^{-\frac{T_{dep}}{T} \left(\frac{H_{dep}}{H}\right)^\mu}$

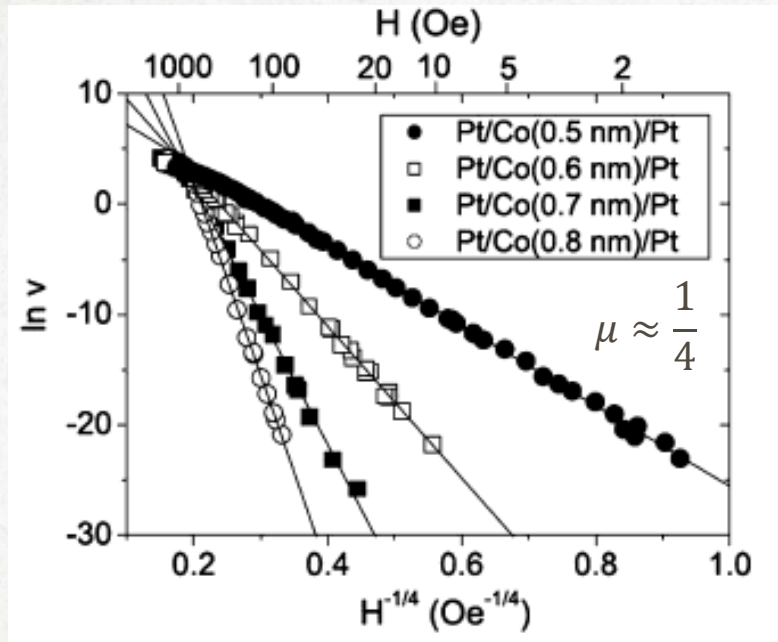
Roughness:

$w(L) = \langle \langle (u(x+L) - u(x))^2 \rangle \rangle \alpha \left(\frac{L}{L_c}\right)^{2\zeta}$

with $\mu = 1/4$ and $\zeta = 2/3$

CREEP REGIME : DW MOTION IN Pt/Co/Pt ULTRATHIN FILMS

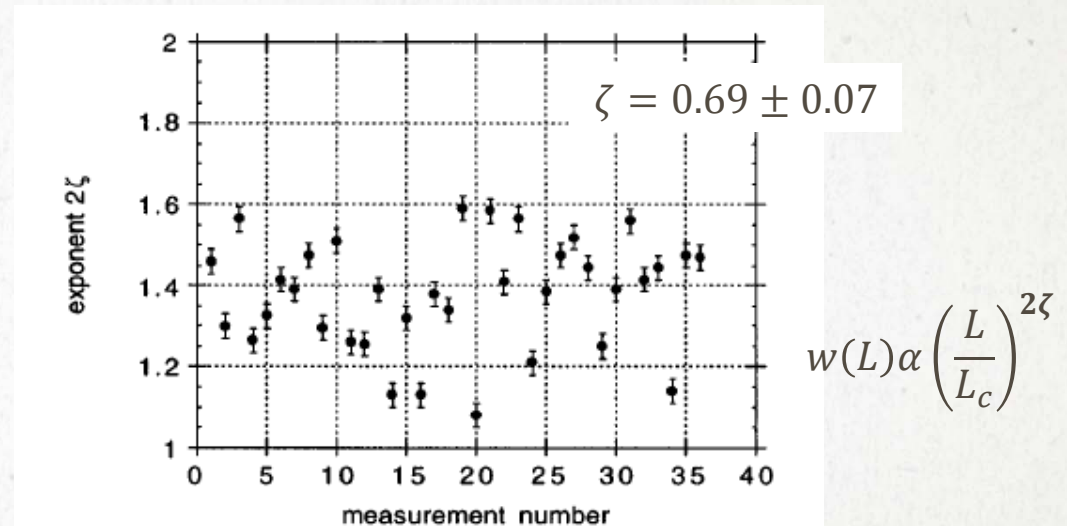
Creep exponent



| |
|----------------------|
| Pt |
| Co |
| Pt |
| Substrate: Si/SiN |

Both scaling laws are compatible with theoretical predictions

Roughness exponent



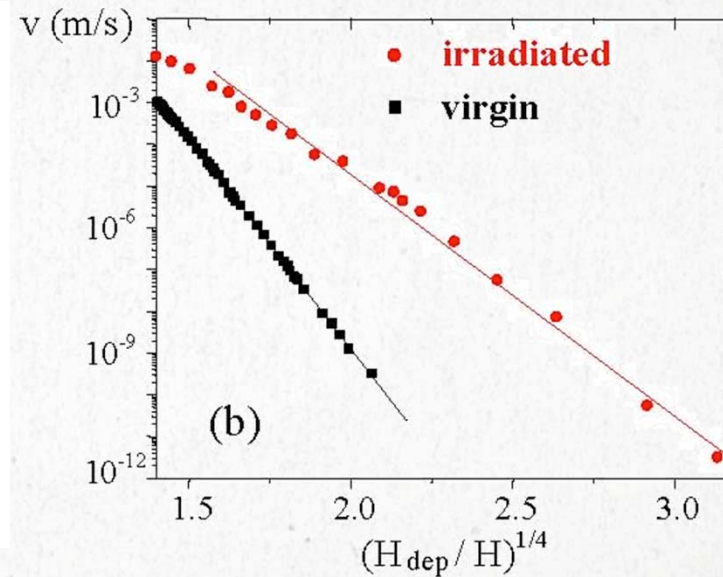
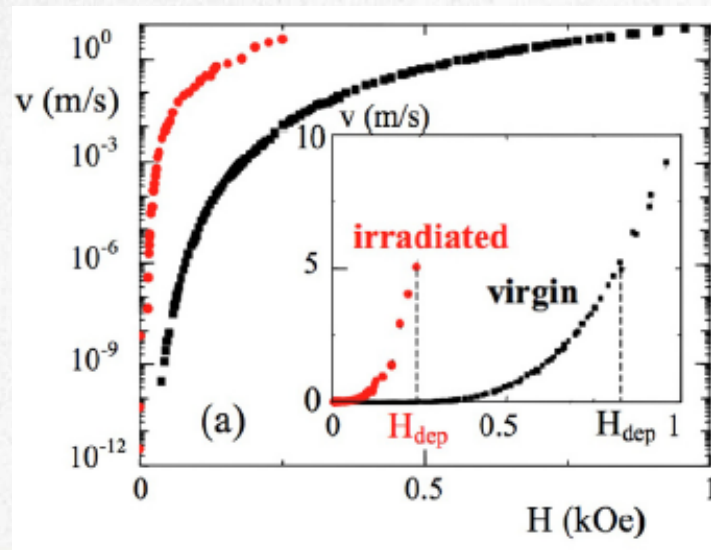
Ultrathin Pt/Co/Pt films: experimental model system to investigate the elastic interface motion in a weakly disordered systems

CONTROLLING DOMAIN WALL CREEP

Irradiations by ion beam

Pt/Co(0.5 nm)/Pt

| |
|----------------------|
| Pt |
| Co |
| Pt |
| Substrate: Si/SiN |



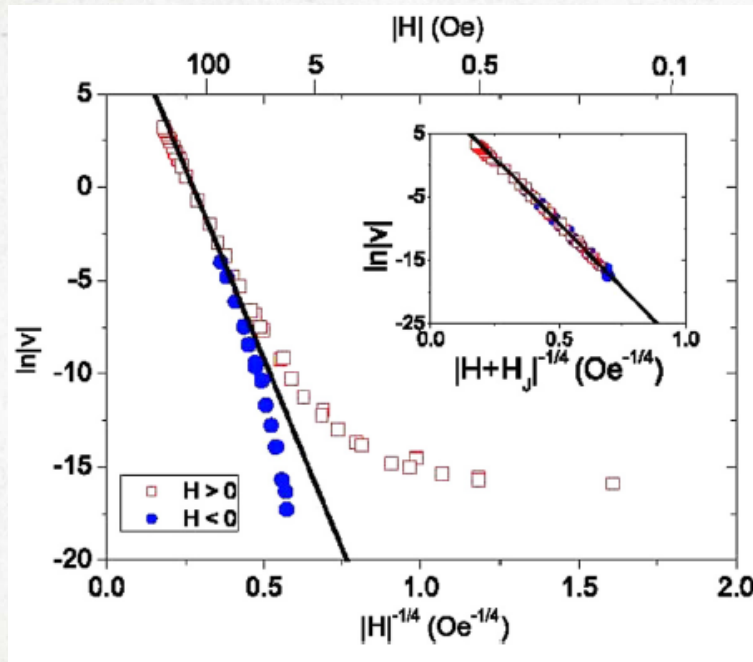
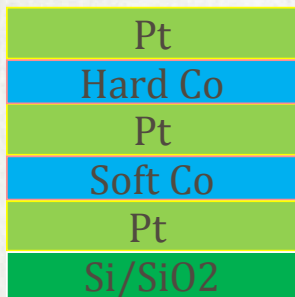
Low dose He⁺ irradiation

⇒ Co and Pt intermixing at the interface: alloying of the Co and smoothing of the nano-irregularities

⇒ reduction of the pinning strength

CONTROLLING DOMAIN WALL CREEP

Creep in presence of an interlayer coupling



Other studies at the LPS:

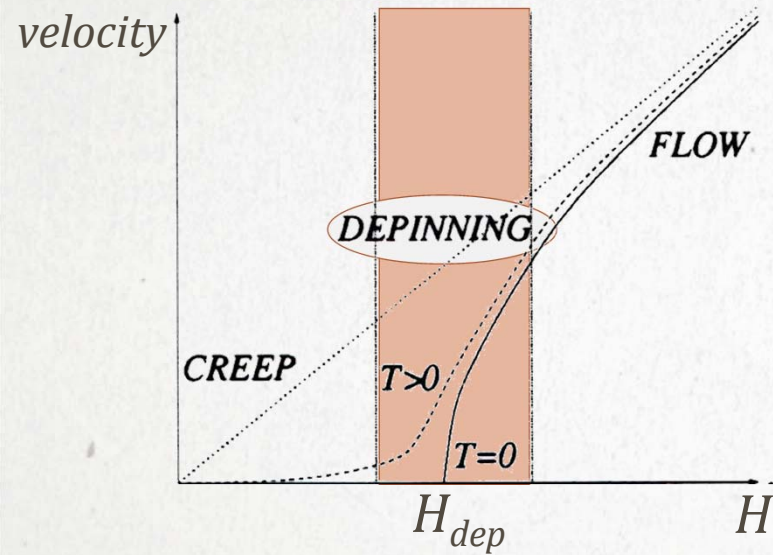
- *Periodic pinning potential*
- *DW deroughening due to dipolar interactions*

- Coupling between the two Co layers (RKKY, dipolar interaction)

- Effective coupling field: $H_J = \frac{J}{M_S t}$

3- THERMAL STUDY OF PINNING DEPENDENT REGIMES

COULD WE BRIDGE THE GAP BETWEEN THE CREEP AND THE FLOW REGIME ?

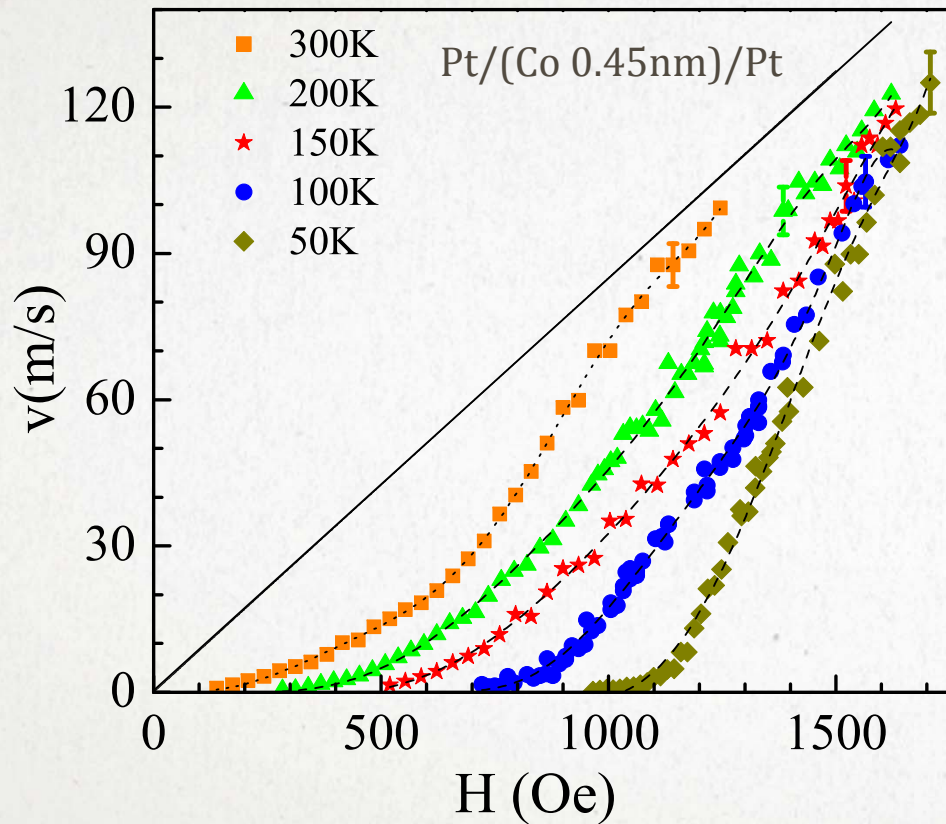


- Single or different regimes?
- Universality?
- Prediction for the depinning transition :

$$v \sim (H - H_{dep})^\beta \text{ and } v(H_{dep}) \sim T^\psi$$

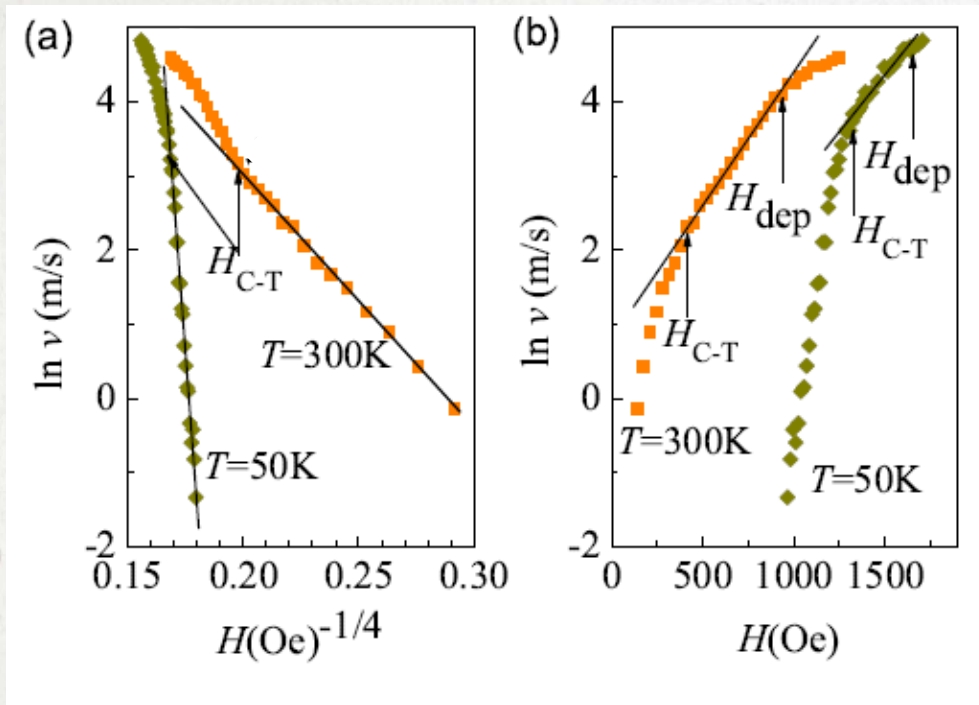
-

FIELD DRIVEN DOMAIN WALL DYNAMICS FOR DIFFERENT TEMPERATURES



- $T \searrow \Rightarrow$ shifts of the curves towards the high field region.
- Nature of the dynamical regimes ?

IDENTIFICATION OF PINNING DEPENDENT REGIMES



Cross over fields: $H_{C-T}(T)$ and $H_{dep}(T)$
 Fit of the creep law $\Rightarrow T_{dep}(T)$ and $v_{creep}^0(T)$

- Creep : $H < H_{C-T}$

$$v_{creep}(H, T) = v_{creep}^0(T) e^{-\frac{T_{dep}}{T} \left(\frac{H_{dep}}{H}\right)^{1/4}}$$

- TAFF : $H_{C-T} < H < H_{dep}$ Thermally Activated Flux Flow

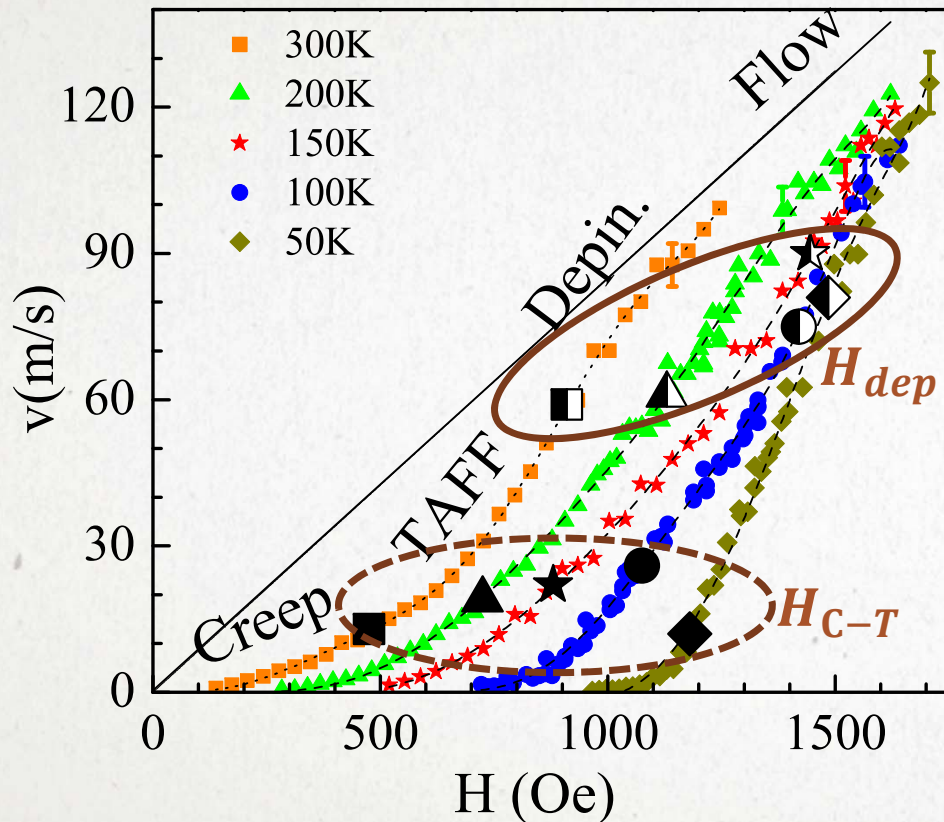
$$v_{TAFF}(H, T) = v_{TAFF}^0(T) e^{-\frac{T_{dep}}{T} \left(1 - \frac{H}{H_{dep}}\right)}$$

- Depinning : $H \geq H_{dep}$

- Flow : $H \gg H_{dep}$

$$m = \frac{v}{H} - DH^{-4} \quad L.W. Chen et al. PRB 51 (1995)$$

IDENTIFICATION OF PINNING DEPENDENT REGIMES



⇒ 3 pinning dependent dynamical regimes

Parameters controlling DW dynamics

- $H_{dep}(T), T_{dep}(T)$

Velocities

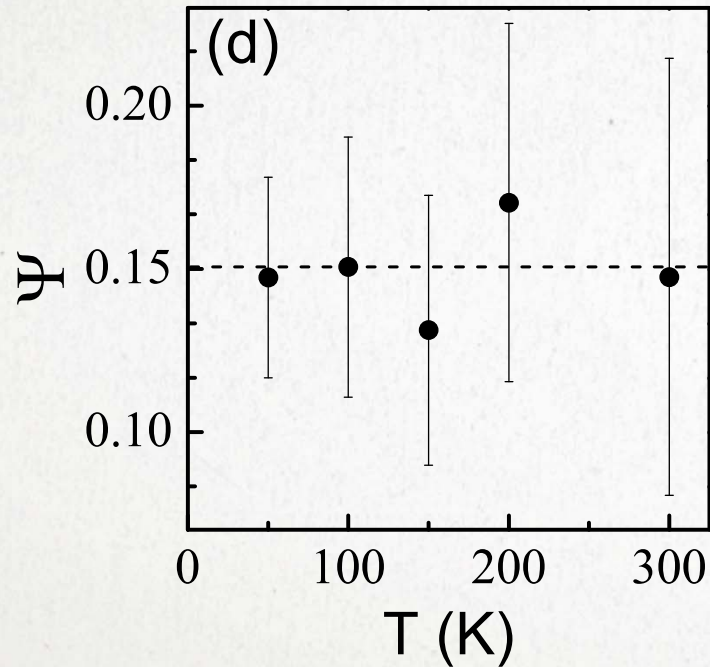
- Mobility in the flow regime: m

- Creep prefactor : $v_{creep}^0(T)$

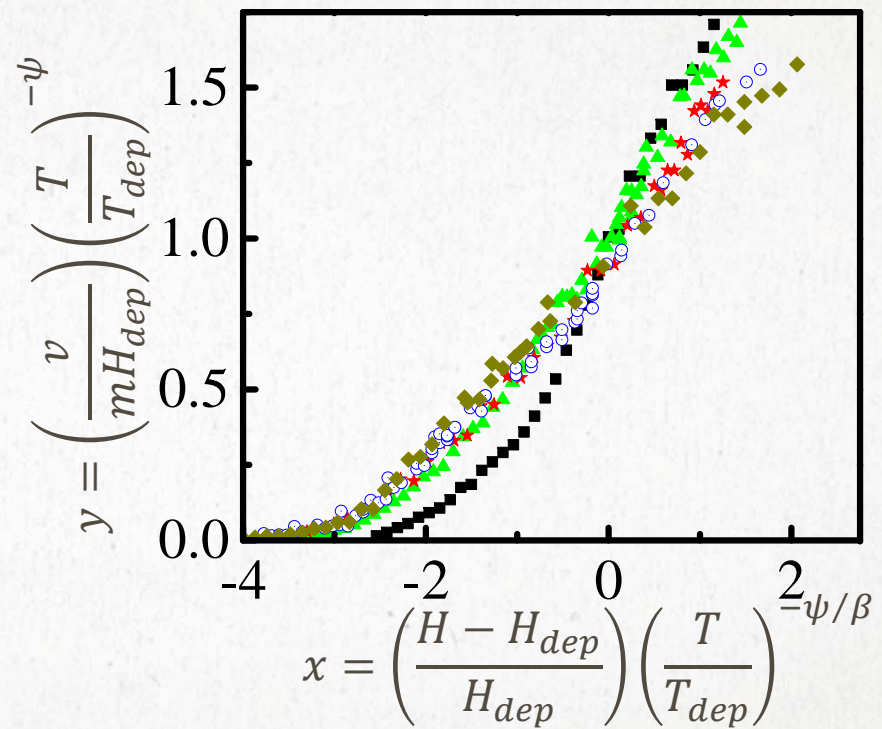
- Velocity at the depinning transition: $v(H_{dep}(T))$

DEPINNING TRANSITION

- Prediction $v(H_{dep}) = mH_{dep} \left(\frac{T}{T_{dep}} \right)^\psi$
with $\psi = 0.15$



Rescaling with $\beta = 0.25$

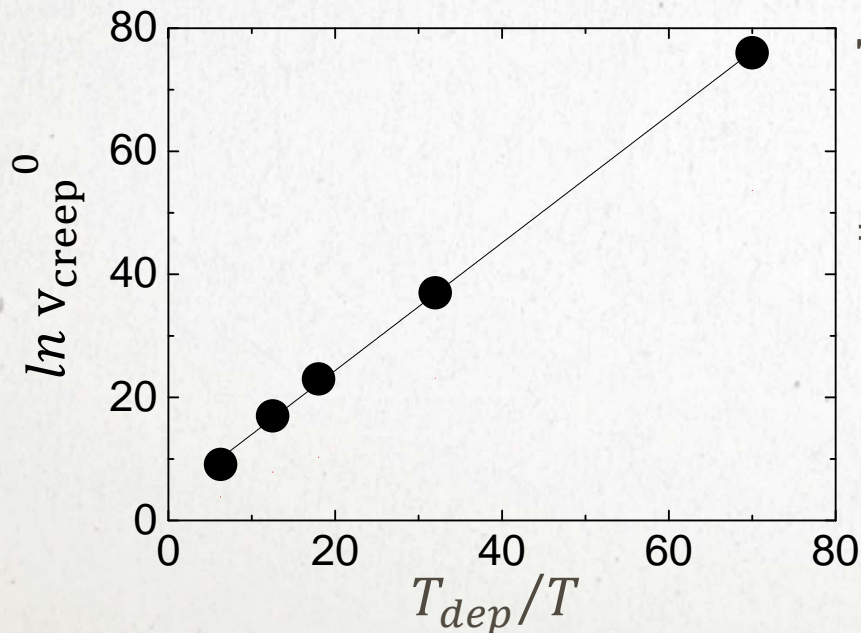


⇒ Universality of the depinning transition

CREEP PREFACTOR

Creep law

$$v_{creep}(H, T) = v_{creep}^0(T) e^{-\frac{T_{dep}}{T} \left(\frac{H_{dep}}{H}\right)^{1/4}}$$



The creep pre-factor is temperature dependent.

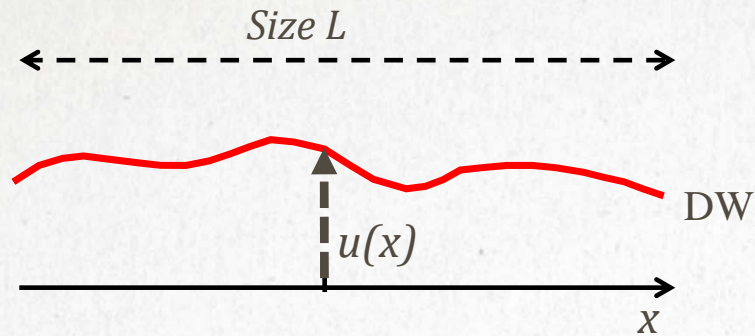
$$\Rightarrow v_{creep}^0(T) = \frac{\xi}{\tau} e^{C \frac{T_{dep}}{T}} \text{ with } C \approx 1.04 \pm 0.02$$

for $\xi = 19nm, \tau = 1ns$ close to typical relaxation time.

$$\Rightarrow \text{Effective attempt frequency: } \frac{1}{\tau_{eff}} = \frac{1}{\tau} e^{C \frac{T_{dep}}{T}}$$

$T_{dep} \searrow \Rightarrow$ more time is spent for the exploration of surrounding pinning sites

MICROSCOPIC PARAMETERS CONTROLLING DW PINNING



Free energy of a DW segment of size L

$$F(L, u) = \underbrace{\epsilon_{el} \frac{u^2}{L}}_{\text{elastic}} - \underbrace{\epsilon_{pin} u \sqrt{n_i \xi L}}_{\text{pinning}} - \underbrace{M_S H t L u}_{\text{Zeeman}}$$

$$\left. \begin{array}{l} \text{Larkin length } L_c \\ \text{Depinning field } H_{dep} \\ \text{Depinning temperature } k_B T_{dep} \end{array} \right\} \Rightarrow \begin{cases} \epsilon_{el} = (k_B T_{dep})^2 / (M_S H_{dep} t) \xi^3 \\ \epsilon_{pin}^2 = [(k_B T_{dep})(M_S H_{dep} t) \xi] / \Delta \\ L_c = (k_B T_{dep}) / [(M_S H_{dep} t) \xi] \end{cases}$$

- Sample characterization \Rightarrow elastic energy ϵ_{el} and magnetization at saturation M_S
- Eq. 1 \Rightarrow correlation length of the disorder $\xi(300 \text{ K}) = 19 \text{ nm}$
 \approx lateral size of Pt crystallites determined by AFM $\Rightarrow \xi$ is T-independent.

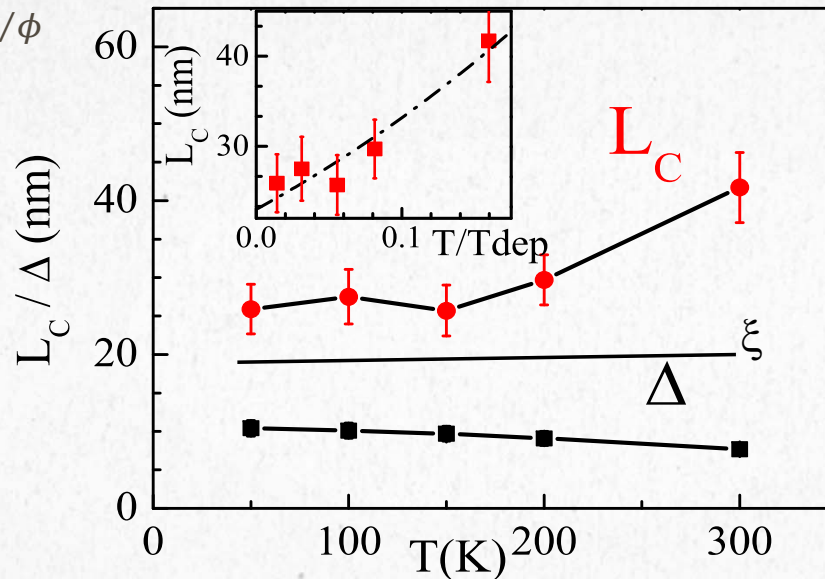
THERMAL SCALING OF THE LARKIN LENGTH

Predictions :

$$L_c(T) = L_c^0 \left(1 + \frac{T}{T_{dep}} \right)^{1/\phi}$$

with $\phi = 0.20$

Thermal crossover exponent

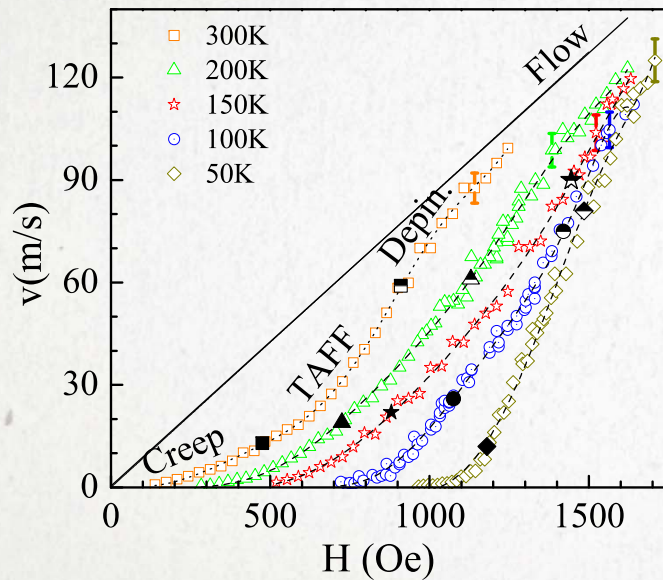


$T_{dep}(T)$ and $H_{dep}(T) \Rightarrow L_c(T)$
 Fit $\Rightarrow L_c^0 = 25 \pm 2 \text{ nm}$ and
 $\phi = 0.24 \pm 0.05$

good agreement \Rightarrow universal thermal dependence of the Larkin length

CONCLUSION ON THERMAL STUDIES AND OPEN QUESTIONS

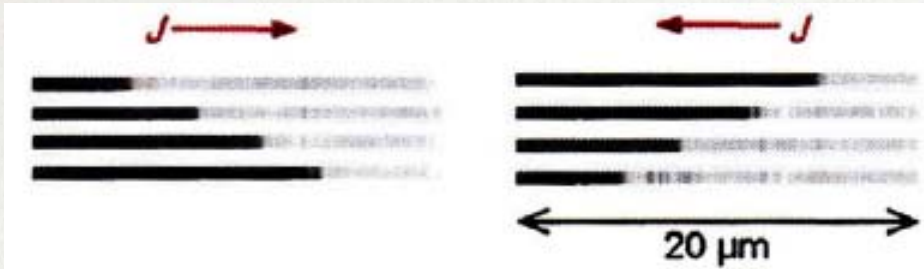
- 3 pinning dependent regimes :
creep, TAFF and depinning



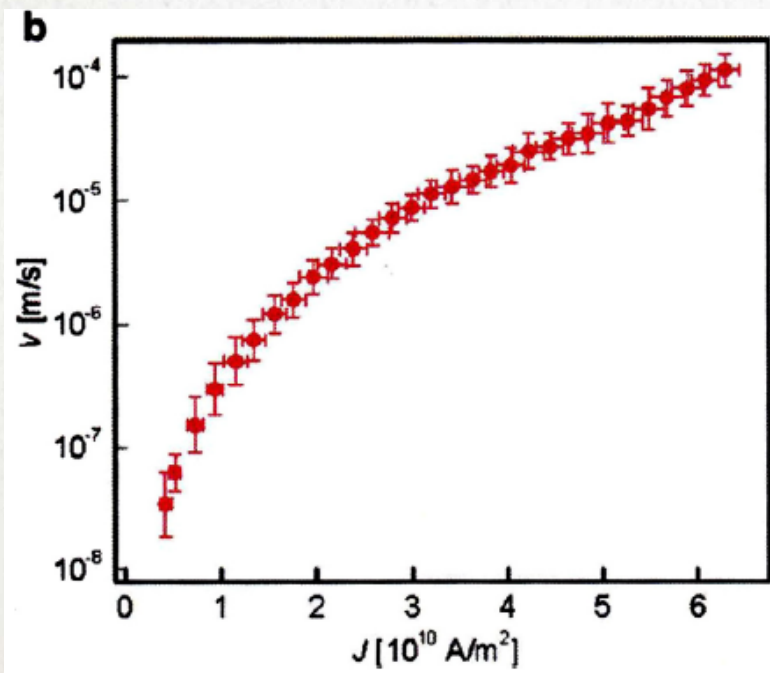
- The creep pre-factor is temperature dependent. Origin ?
- Depinning transition: universal thermal scaling exponent $\psi = 0.15$
- Larkin length: universal thermal exponent $\varphi = 0.24$
- TAFF regime : universal? Origin ?
- and...

4- DOMAIN WALL MOTION DRIVEN BY AN ELECTRIC CURRENT

CURRENT DRIVEN DW MOTION IN A TRACK



DW motion due to a spin transfer torque between the spin of the carriers and the local magnetization.

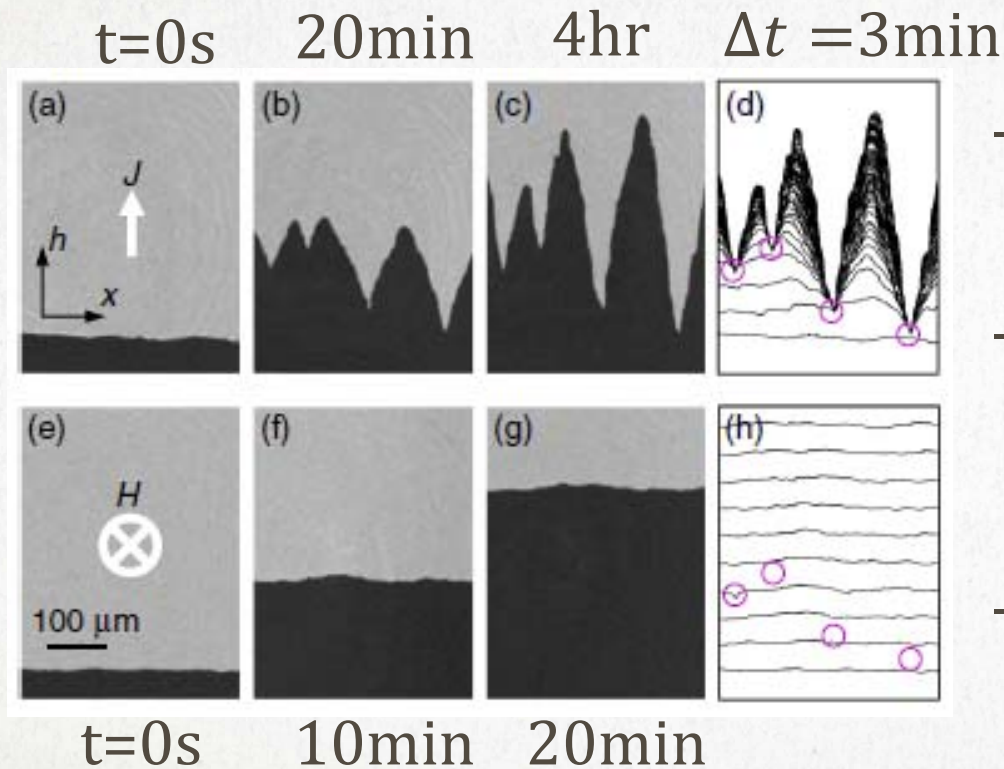


$$v = v_0 e^{-\left[\frac{T_{dep}}{T+aJ^2} \left(\frac{H_{dep}}{H} + bJ \right)^\mu \right]} \text{ with } \mu \approx \frac{1}{4}$$

Same creep exponent as for field-driven DW motion

CURRENT DRIVEN DW MOTION IN EXTENDED GEOMETRY

$$J = 10^{10} \text{ A/m}^2$$



$$H = 1 \text{ mT}$$

Pt/Co(0.3)/Pt

- Correlation between the DW velocity and its shape
- Different roughness exponent: $\zeta_H = 0.68 \pm 0.04$
 $\zeta_J = 0.99 \pm 0.01$
- Physics of the formation of the mountains ?

CONCLUSION

- **Ultrathin Pt/Co/Pt films:**
Model system to investigate the elastic interface motion in a weakly disordered systems
- **Thermal study:**
 - **Evidence of 3 distinct pinning dependent regimes : creep, TAFE, and depinning**
 - **Determination of the universal scaling laws for the depinning transition**
 - **Extraction of (non-universal) microscopic length and energy scales**

PERSPECTIVES

- **Transient creep regime**
- **Current induced DW motion**